

September 2010 UniFET-II

FDP10N60NZ / FDPF10N60NZ N-Channel MOSFET 600V, 10A, 0.75Ω

Features

- $R_{DS(on)} = 0.64\Omega$ (Typ.)@ $V_{GS} = 10V$, $I_D = 5A$
- Low Gate Charge (Typ. 23nC)
- Low C_{rss} (Typ. 10pF)
- Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- ESD Improved Capability
- RoHS compliant

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol		FDP10N60NZ	FDPF10N60NZ	Units			
V _{DSS}	Drain to Source Voltage	6	V				
V _{GSS}	Gate to Source Voltage			ŧ	V		
I _D	Drain Current	- Continuous ($T_C = 25^{\circ}C$)		10	10*	A	
	Drain Current	- Continuous ($T_C = 100^{\circ}C$)		6	6*		
I _{DM}	Drain Current	- Pulsed	(Note 1)	40	40*	А	
E _{AS}	Single Pulsed Avalanche Energy			5	mJ		
I _{AR}	Avalanche Current			10		А	
E _{AR}	Repetitive Avalanche Energy			1	mJ		
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	10		V/ns	
P _D	Dower Dissipation	$(T_{C} = 25^{\circ}C)$		185	38	W	
	Power Dissipation	- Derate above 25°C	- Derate above 25°C		0.3	W/ºC	
T _J , T _{STG}	Operating and Storage Temperature Range			-55 t	°C		
Τ _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			Э	°C		

*Dran current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDP10N60NZ	FDPF10N60NZ	Units
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	0.68	3.3	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ	0.5	-	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

		Packa			Тар	e Width		Quantit	y	
		TO-22				-		50		
FDPF10N60NZ FDPF10N60NZ TO-22		TO-22	0F		-	50				
Electrica	l Char	acteristics T _C =	25ºC unless	otherwi	se noted					
Symbol	Parameter			Test Conditions			Min.	Тур.	Max.	Unit
Off Charac	teristic	S								
BV _{DSS}	Drain to Source Breakdown Voltage			$I_D = 250 \mu A, V_{GS} = 0V, T_J = 25^{\circ}C$			600	-	-	V
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient		ire	$I_D = 250\mu A$, Referenced to $25^{\circ}C$			-	0.6	-	V/ºC
-	7				$V_{DS} = 600V, V_{GS} = 0V$			-	1	•
DSS	DSS Zero Gate Voltage Drain Current			$V_{DS} = 480V, T_{C} = 125^{\circ}C$			-	-	10	μA
I _{GSS}	Gate to	Body Leakage Current	t	$V_{GS} =$	$\pm 25V, V_{DS} = 0V$		-	-	±10	μA
On Charac	teristic	s								
V _{GS(th)}	Gate Threshold Voltage			$V_{GS} = V_{DS}, I_{D} = 250 \mu A$			3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance			$V_{GS} = 10V, I_D = 5A$			-	0.64	0.75	Ω
9 _{FS}	Forward Transconductance			$V_{\rm DS} = 20V, I_{\rm D} = 5A$ -			-	14	-	S
C _{iss} C _{oss}	Input C Output	aracteristics nput Capacitance Dutput Capacitance Reverse Transfer Capacitance		V _{DS} = 25V, V _{GS} = 0V f = 1MHz			-	1110 130 10	1475 175 15	pF pF
C _{rss}		Reverse Transfer Capacitance				-	23	30	nC	
Q _g	Total Gate Charge at 10V Gate to Source Gate Charge		V _{DS} = 480V, I _D = 10A V _{GS} = 10V			_	6		nC	
Q _{gs} Q _{gd}	Gate to Source Gate Charge Gate to Drain "Miller" Charge					-	8	-	nC	
Switching										
t _{d(on)}	1	n Delay Time					-	25	60	ns
t _r		urn-On Rise Time		$V_{DD} = 300V, I_D = 10A$			-	50	110	ns
t _{d(off)}	Turn-Off Delay Time		$-R_{G} = 25\Omega$			-	70	150	ns	
t _f	Turn-Of	rn-Off Fall Time			_			50	110	ns
Drain-Sou	rce Dio	de Characteristic	s	1			I			
I _s	Maximum Continuous Drain to Source Diod			le Forwa	ard Current		-	-	10	A
I _{SM}	Maximum Pulsed Drain to Source Diode Fo						-	-	40	Α
V _{SD}	Drain to Source Diode Forward Voltage		V _{GS} = 0V, I _{SD} = 10A			-	-	1.4	V	
t _{rr}	Reverse Recovery Time			$V_{GS} = 0V, I_{SD} = 10A$			-	300	-	ns
Q _{rr}	Reverse Recovery Charge			dl _F /dt = 100A/μs -			-	2	-	μC

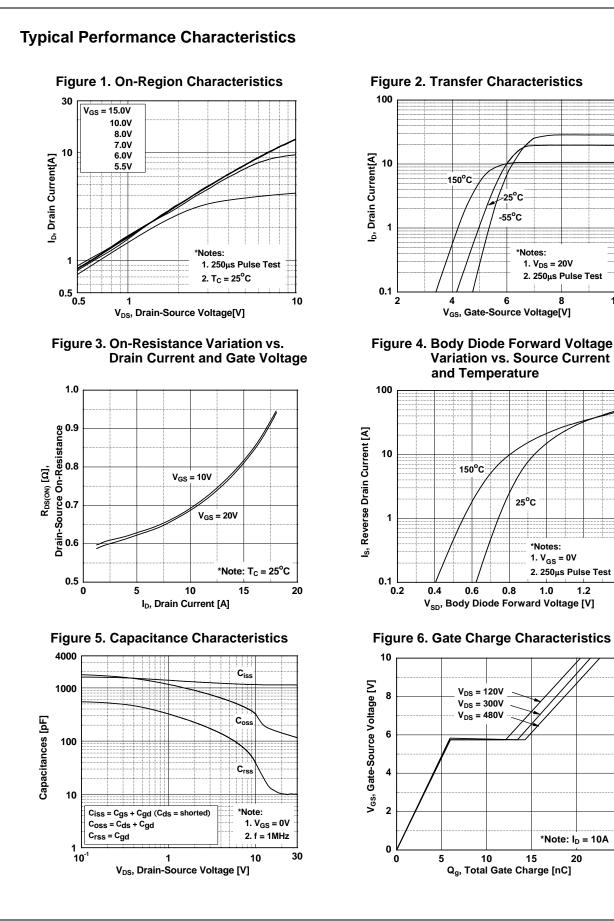
 $\begin{array}{l} \text{2. L} = 11\text{mH}, \ I_{AS} = 10\text{A}, \ V_{DD} = 50\text{V}, \ R_G = 25\Omega, \ \text{Starting} \ T_J = 25^\circ \\ \text{3. I}_{SD} \leq 10\text{A}, \ \text{di/dt} \leq 200\text{A}/\mu\text{s}, \ V_{DD} \leq \text{BV}_{DSS}, \ \text{Starting} \ T_J = 25^\circ\text{C} \\ \end{array}$

4.Pulse test: Pulse width $\leq 300 \mu$ s,Duty Cycle $\leq 2\%$

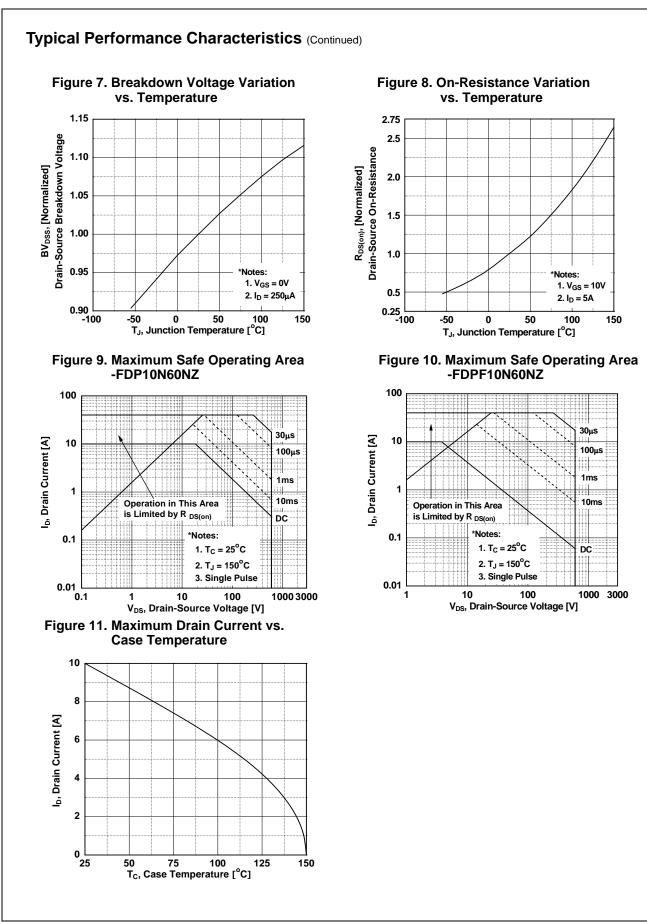
5. Essentially Independent of Operating Temperature Typical Characteristics

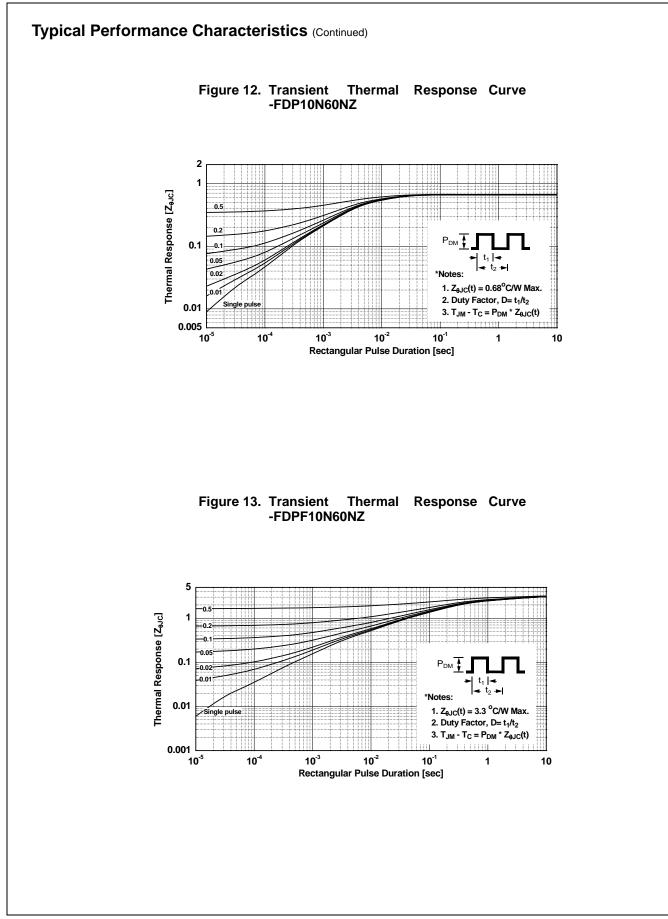
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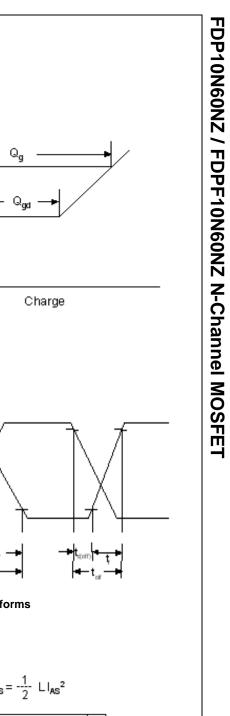
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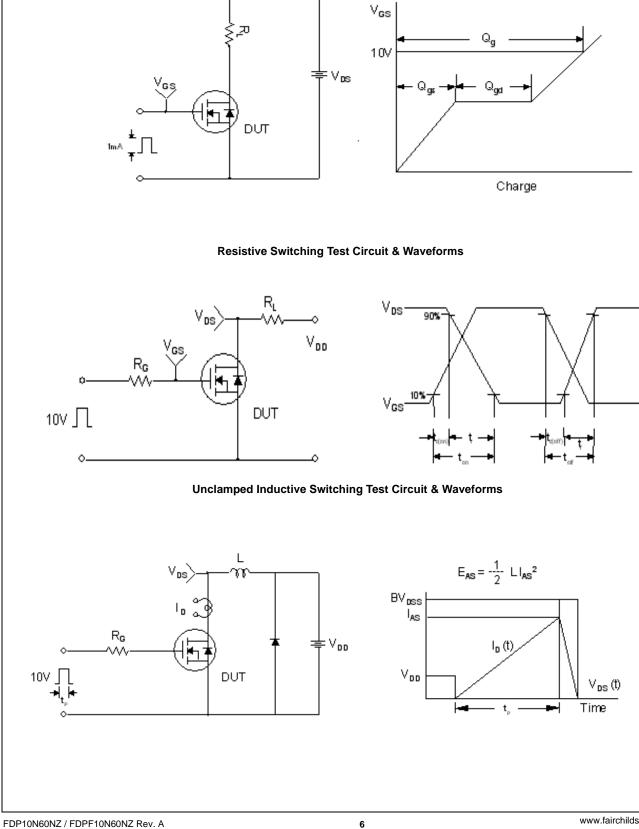


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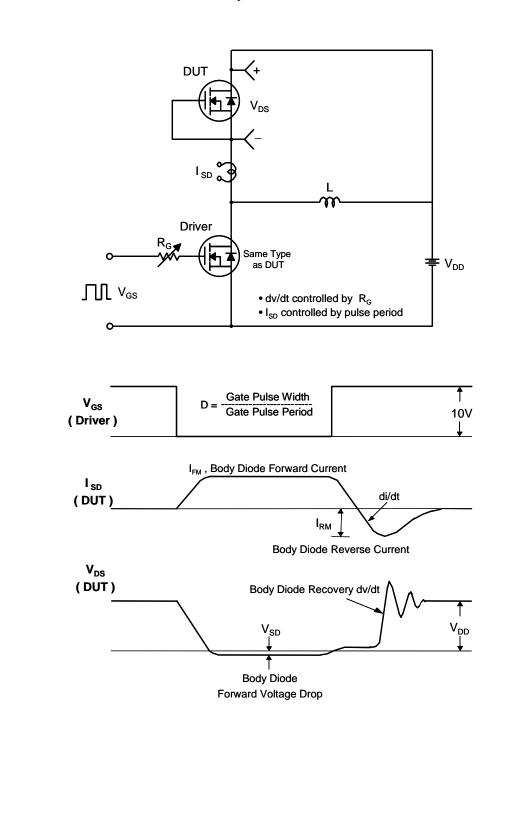




Gate Charge Test Circuit & Waveform

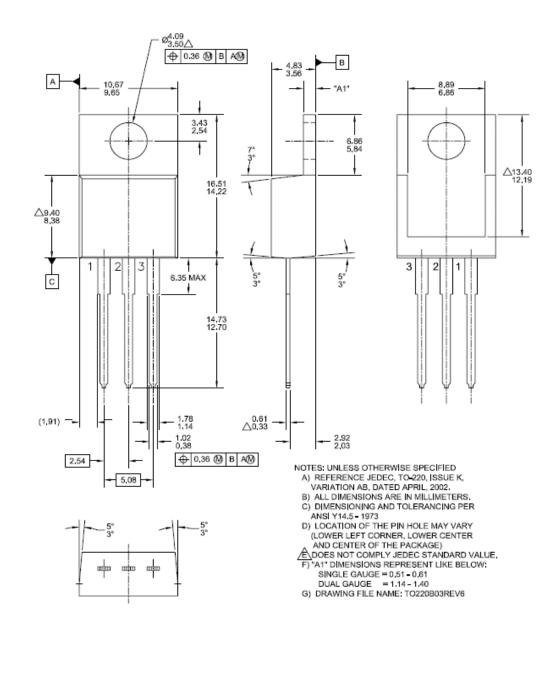
FDP10N60NZ / FDPF10N60NZ N-Channel MOSFET



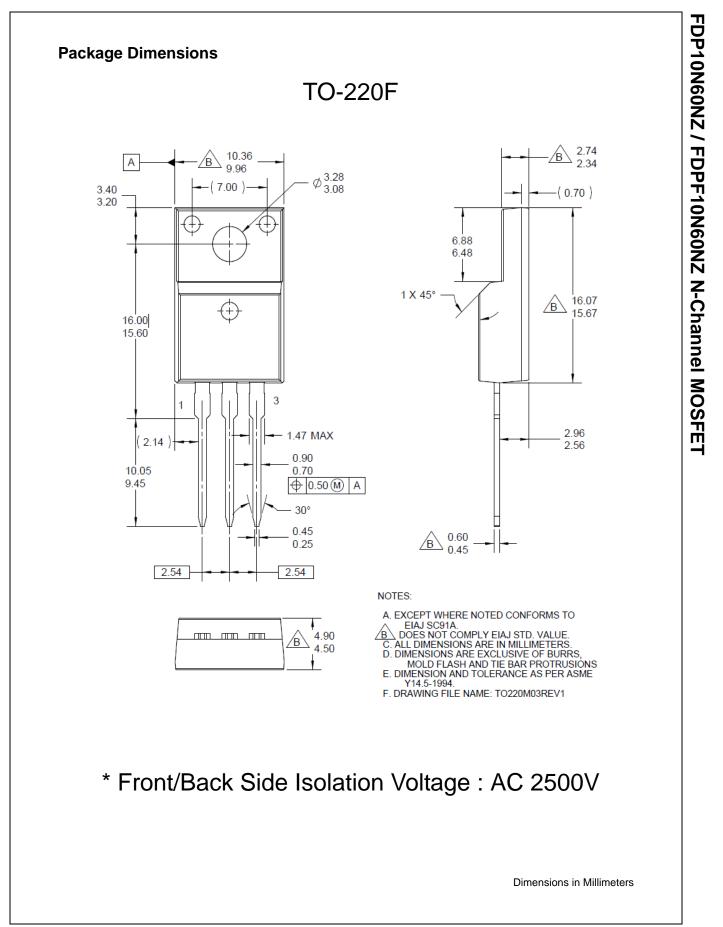


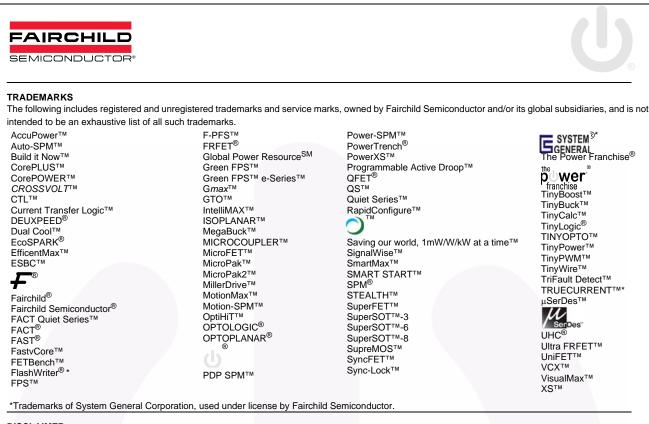
Mechanical Dimensions

TO-220



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